

# UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/709,209	04/21/2004	Dwadasi Hare Rama Sarma	DP-305691	3208
22851 7590 01/09/2007 DELPHI TECHNOLOGIES, INC.		EXAMINER		
M/C 480-410-202			PATEL, ISHWARBHAI B	
PO BOX 5052 TROY, MI 48007			ART UNIT	PAPER NUMBER
1 KO 1, WII 400	01		2841	
SHORTENED STATUTOR	Y PERIOD OF RESPONSE	MAIL DATE	DELIVERY MODE	
3 MONTHS		01/09/2007	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

If NO period for reply is specified above, the maximum statutory period will apply and will expire 6 MONTHS from the mailing date of this communication.

•		Application No.	Applicant(s)	
Office Action Server		10/709,209	SARMA ET AL.	
	Office Action Summary	Examiner	Art Unit	
		Ishwar (I. B.) Patel	2841	
 eriod for	The MAILING DATE of this communicate Reply	ion appears on the cover sheet wit	th the correspondence address	
A SHO WHICH - Extensi after SI - If NO p - Failure Any rep	RTENED STATUTORY PERIOD FOR IEVER IS LONGER, FROM THE MAIL ons of time may be available under the provisions of 37 X (6) MONTHS from the mailing date of this communic eriod for reply is specified above, the maximum statuto to reply within the set or extended period for reply will, ly received by the Office later than three months after the patent term adjustment. See 37 CFR 1.704(b).	ING DATE OF THIS COMMUNIC CFR 1.136(a). In no event, however, may a reation. Ty period will apply and will expire SIX (6) MON by statute, cause the application to become AB,	CATION.  eply be timely filed  THS from the mailing date of this communication.  ANDONED (35 U.S.C. § 133).	
tatus	,			
_	Responsive to communication(s) filed o	n 01 Dagambar 2006		
	_	☐ This action is non-final.		
′=	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is			
	losed in accordance with the practice t		•	
		maor Expano quayro, 1000 0.D.	. 11, 100 0.0.210.	
·	n of Claims			
	Claim(s) <u>1-20</u> is/are pending in the appl			
	a) Of the above claim(s) <u>5 and 11-20</u> is	rare withdrawn from consideration	n.	
·	claim(s) is/are allowed.			
	Claim(s) <u>1-4 and 6-10</u> is/are rejected.			
· · · · · · · · · · · · · · · · · · ·	claim(s) is/are objected to.			
ا 🗀 (8	claim(s) are subject to restriction	and/or election requirement.		
pplicatio	n Papers			
9)∐ TI	ne specification is objected to by the Ex	kaminer.		
10)⊠ TI	ne drawing(s) filed on <u>04 April 2006</u> is/a	are: a)⊠ accepted or b)⊡ objec	ted to by the Examiner.	
A	pplicant may not request that any objection	to the drawing(s) be held in abeyand	ce. See 37 CFR 1.85(a).	
F	eplacement drawing sheet(s) including the	correction is required if the drawing(	s) is objected to. See 37 CFR 1.121(d).	
11)[] TI	ne oath or declaration is objected to by	the Examiner. Note the attached	Office Action or form PTO-152.	
iority un	der 35 U.S.C. § 119			
	cknowledgment is made of a claim for a cla	foreign priority under 35 U.S.C. §	119(a)-(d) or (f).	
,	. Certified copies of the priority doc	uments have been received.		
	. Certified copies of the priority doc		oplication No.	
	. Copies of the certified copies of the	•		
	application from the International	· · · · · · · · · · · · · · · · · · ·		
* Se	e the attached detailed Office action fo		received.	
tachment(s	)			
	of References Cited (PTO-892)		ummary (PTO-413)	
	of Draftsperson's Patent Drawing Review (PTO-	Paper No(s)	)/Mail Date formal Patent Application	
	tion Disclosure Statement(s) (PTO/SB/08) lo(s)/Mail Date	6) Other:		

### **DETAILED ACTION**

#### Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on December 1, 2006 has been entered.

## Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-4 and 6-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Polinski (US Patent No. 5,386,339).

Regarding claim 1, Polinski, in an embodiment of figure 5, discloses a circuit board assembly comprising: a co-fired substrate comprising at least first (made up of sheet 122) and second (made up of 148) regions superimposed and bonded to each other, the first region being formed of a plurality of first ceramic layers (LTCC sheet

122), each first ceramic layer consisting essentially of electrically-nonconductive materials (dielectric structure 124, column 6, line 1,2), at least some of the first ceramic layers being bonded to each other (see figure), the second region being formed of at least one second ceramic layer (148), conductor lines on at least some of the first ceramic layers so as to be between adjacent pairs of the first ceramic layers: electrically-conductive vias that extend through at least some of the first ceramic layers and electrically interconnect the conductor lines on the first ceramic layers (explained in the first embodiment, column 3, line 59-64); and a surface-mount IC device (130) mounted to a first surface of the substrate defined by one of the first ceramic layers, wherein said first and second regions are arranged for serial thermal interconnection between said IC device and an opposed heat sink (24), wherein each first ceramic layer and said at least one second ceramic layer have substantially similar width and length characteristic dimension (see figure). Polinski, though discloses the second region (148) with higher thermally conductivity (column 5, line 58-59), does not explicitly disclose thermally-conductive particles dispersed in a matrix comprising electricallynonconductive materials, the thermally-conductive particles having a higher coefficient of thermal conductivity than the electrically-nonconductive materials of the first and second ceramic layers. However, Polinski further recites that additives can be added to improve the thermal conductivity (column 4, line 36-44).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time of applicant's invention to provide the second region (148) be formed with thermally-conductive particles dispersed in a matrix comprising electrically-

nonconductive materials, the thermally-conductive particles having a higher coefficient of thermal conductivity than the electrically-nonconductive materials of the first and second ceramic layers, in order to have higher thermal conductivity of the second region for fast dissipation of heat from the system.

Regarding claim 2, Polinski further discloses the substrate is a low-temperature co-fired ceramic substrate (sheets 122 and 148 made of low-temperature co-fired ceramic material, column 6, lien 1,2 and column 5, line 45).

**Regarding claim 3,** Polinski further discloses the thermally conductive particles are metal and/or ceramic particles (column 4, line 37-52).

Regarding claim 4, the substrate of Polinski does not have thermal via extending through the substrate from the surface mount device on the first surface to an oppositely disposed second surface of the substrate (no via in the second region 148, see figure).

Regarding claim 6, Polinski discloses all the features of the claimed invention but does not disclose the second ceramic layers have a coefficient of thermal expansion of within about 4 ppm/°C of first ceramic layers. However, it is advisable to control the coefficient of thermal expansion of both layers of first and second region to avoid developing cracks at the bonding junction due the uneven expansion. Further the

coefficient of thermal expansion will depend upon the additive used in the layers and can be controlled by changing the proportion and type of additives. Furthermore, it has been held that discovering an optimum value of a result effective variable involves only routine skill in the art. *In re Boesch*, 617 F.2d 272, 205 USPQ 215 (CCPA 1980).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time of applicant's invention to keep the coefficient of thermal expansion as close as possible to that of the first ceramic layers, and for that matter within about 4 ppm/°C of first ceramic layers, in order to avoid crack development at the bonding junction.

Regarding claim 7, Polinski discloses all the features of the claimed invention including the second ceramic layers but does not disclose the second ceramic layers have a thermal conductivity of at least 10 W/mK. However, as applied to claim 1 above, additives are added to improve the thermal conductivity to the desired value to facilitate faster heat removal to protect the device from the damage. Further, it has been held that discovering an optimum value of a result effective variable involves only routine skill in the art. *In re Boesch*, 617 F.2d 272, 205 USPQ 215 (CCPA 1980).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time of applicant's invention to provide structure of Polinski with the second ceramic layers have a thermal conductivity of at least 10 W/mK, in order to have desired thermal conductivity to avoid damage to the system due to higher temperature.

Regarding claim 8, Polinski discloses all the features of the claimed invention including the second region free of the first ceramic layers, the first ceramic layers are bonded surface-to-surface to form the first region of the substrate, and the first region is free of the second ceramic layers and is bonded to the second region of the substrate (see figure), but does not disclose the second ceramic layer is one of a plurality of second ceramic layers bonded surface-to-surface to form the second region of the substrate. However, the second region of Polinski is made of higher thermal conductivity to facilitate faster heat removal. Adding more layer will help in enhancing heat removal. Therefore, it would have been obvious to a person of ordinary skill in the art to modify the structure of Polinski having the second ceramic layer is one of a plurality of second ceramic layers bonded surface-to-surface to form the second region of the substrate, in order to enhance heat removal rate to avoid damage to the system.

**Regarding claim 9,** Polinski further discloses a heat sink (24) bonded to the substrate, the second region of the substrate being between the heat sink and the first region of the substrate (see figure).

Regarding claim 10, Polinski discloses all the features of the claimed invention including the first region formed of first ceramic layers and the second region formed on second ceramic layers, wherein each first ceramic layer and said at least one second ceramic layer have substantially similar width and length characteristic dimension and a

surface mount IC device mounted to a first surface of the substrate and an opposed heat sink, as applied to claims 1, 4, 6, 7 and 8.

## Response to Arguments

4. Applicant's arguments filed on December 1, 2006 have been fully considered but they are not persuasive.

Applicant on page 10 of the response argues that the low thermal conductivity sheets (first ceramic layer) of prior art of Polinski are segmented and do not extend laterally and longitudinally coextensively with high thermal conductive sheets (second ceramic layer). This is not found to be persuasive. Though first ceramic sheets (122) of Polinski are segmented and have different material characteristic through out the length and width of the sheet, as can be seen in the figure, width and length characteristic dimensions are similar to that of the second ceramic layer (148). Therefore the structure of Polinski read on the recited claim. Therefore, Polinski meets the limitation.

#### Conclusion

5. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Ishikawa in figure 1 discloses a structure with component 16 mounted on ceramic substrate 22 and heat sink 20 and 18.

Application/Control Number: 10/709,209

Art Unit: 2841

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Ishwar (I. B.) Patel whose telephone number is (571) 272 1933. The examiner can normally be reached on M-F (8:30 - 5:00).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Dean Reichard can be reached on (571) 272 1984. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

ibp

December 28, 2006

Ishwar (I. B.) Patel Primary Examiner Page 8